

### General Description

The AO4616 uses advanced trench technology to provide excellent  $R_{DS(ON)}$  and low gate charge. This complementary N and P channel MOSFET configuration is ideal for low Input Voltage inverter applications.

### Product Summary

#### N-Channel

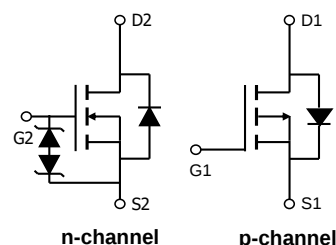
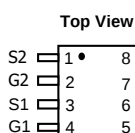
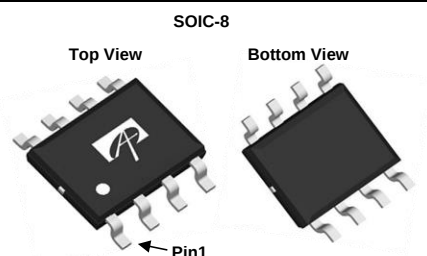
$V_{DS} = 30V$   
 $I_D = 8A$  ( $V_{GS} = 10V$ )  
 $R_{DS(ON)} < 20m\Omega$  ( $V_{GS} = 10V$ )  
 $< 28m\Omega$  ( $V_{GS} = 4.5V$ )

100% UIS Tested  
100%  $R_g$  Tested  
**ESD Protected**

#### P-Channel

$-30V$   
 $-7A$  ( $V_{GS} = -10V$ )  
 $R_{DS(ON)} < 22m\Omega$  ( $V_{GS} = -10V$ )  
 $< 40m\Omega$  ( $V_{GS} = -4.5V$ )

100% UIS Tested  
100%  $R_g$  Tested



### Absolute Maximum Ratings $T_A = 25^\circ C$ unless otherwise noted

| Parameter                               | Symbol           | Max n-channel | Max p-channel | Units      |
|-----------------------------------------|------------------|---------------|---------------|------------|
| Drain-Source Voltage                    | $V_{DS}$         | 30            | -30           | V          |
| Gate-Source Voltage                     | $V_{GS}$         | $\pm 20$      | $\pm 20$      | V          |
| Continuous Drain Current                | $I_D$            | 8             | -7            | A          |
| $T_A = 25^\circ C$                      |                  | 6.5           | -6            |            |
| Pulsed Drain Current <sup>C</sup>       | $I_{DM}$         | 40            | -40           | A          |
| Avalanche Current <sup>C</sup>          | $I_{AS}, I_{AR}$ | 19            | 27            | A          |
| Avalanche energy $L=0.1mH$ <sup>C</sup> | $E_{AS}, E_{AR}$ | 18            | 36            | mJ         |
| Power Dissipation <sup>B</sup>          | $P_D$            | 2             | 2             | W          |
| $T_A = 25^\circ C$                      |                  | 1.3           | 1.3           |            |
| Junction and Storage Temperature Range  | $T_J, T_{STG}$   | -55 to 150    |               | $^\circ C$ |

### Thermal Characteristics

| Parameter                                  | Symbol          | Typ | Max  | Units        |
|--------------------------------------------|-----------------|-----|------|--------------|
| Maximum Junction-to-Ambient <sup>A</sup>   | $R_{\theta JA}$ | 48  | 62.5 | $^\circ C/W$ |
| $t \leq 10s$                               |                 | 74  | 90   | $^\circ C/W$ |
| Maximum Junction-to-Ambient <sup>A,D</sup> | $R_{\theta JL}$ | 32  | 40   | $^\circ C/W$ |
| Steady-State                               |                 |     |      |              |

**N-Channel Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions                                                                         | Min | Typ        | Max      | Units            |
|-----------------------------|---------------------------------------|------------------------------------------------------------------------------------|-----|------------|----------|------------------|
| <b>STATIC PARAMETERS</b>    |                                       |                                                                                    |     |            |          |                  |
| $BV_{DSS}$                  | Drain-Source Breakdown Voltage        | $I_D=250\mu\text{A}$ , $V_{GS}=0\text{V}$                                          | 30  |            |          | V                |
| $I_{DSS}$                   | Zero Gate Voltage Drain Current       | $V_{DS}=30\text{V}$ , $V_{GS}=0\text{V}$<br>$T_J=55^\circ\text{C}$                 |     |            | 1<br>5   | $\mu\text{A}$    |
| $I_{GSS}$                   | Gate-Body leakage current             | $V_{DS}=0\text{V}$ , $V_{GS}=\pm 16\text{V}$                                       |     |            | 10       | $\mu\text{A}$    |
| $V_{GS(th)}$                | Gate Threshold Voltage                | $V_{DS}=V_{GS}$ , $I_D=250\mu\text{A}$                                             | 1.2 | 1.8        | 2.4      | V                |
| $I_{D(ON)}$                 | On state drain current                | $V_{GS}=10\text{V}$ , $V_{DS}=5\text{V}$                                           | 40  |            |          | A                |
| $R_{DS(ON)}$                | Static Drain-Source On-Resistance     | $V_{GS}=10\text{V}$ , $I_D=8\text{A}$<br>$T_J=125^\circ\text{C}$                   |     | 16.5<br>23 | 20<br>28 | $\text{m}\Omega$ |
|                             |                                       | $V_{GS}=4.5\text{V}$ , $I_D=6\text{A}$                                             |     | 19.5       | 28       | $\text{m}\Omega$ |
| $g_{FS}$                    | Forward Transconductance              | $V_{DS}=5\text{V}$ , $I_D=8\text{A}$                                               |     | 30         |          | S                |
| $V_{SD}$                    | Diode Forward Voltage                 | $I_S=1\text{A}$ , $V_{GS}=0\text{V}$                                               |     | 0.75       | 1        | V                |
| $I_S$                       | Maximum Body-Diode Continuous Current |                                                                                    |     |            | 2.5      | A                |
| <b>DYNAMIC PARAMETERS</b>   |                                       |                                                                                    |     |            |          |                  |
| $C_{iss}$                   | Input Capacitance                     | $V_{GS}=0\text{V}$ , $V_{DS}=15\text{V}$ , $f=1\text{MHz}$                         | 600 | 740        | 888      | pF               |
| $C_{oss}$                   | Output Capacitance                    |                                                                                    | 77  | 110        | 145      | pF               |
| $C_{rss}$                   | Reverse Transfer Capacitance          |                                                                                    | 50  | 82         | 115      | pF               |
| $R_g$                       | Gate resistance                       | $V_{GS}=0\text{V}$ , $V_{DS}=0\text{V}$ , $f=1\text{MHz}$                          | 0.5 | 1.1        | 1.7      | $\Omega$         |
| <b>SWITCHING PARAMETERS</b> |                                       |                                                                                    |     |            |          |                  |
| $Q_g(10\text{V})$           | Total Gate Charge                     | $V_{GS}=10\text{V}$ , $V_{DS}=15\text{V}$ , $I_D=8\text{A}$                        | 12  | 15         | 18       | nC               |
| $Q_g(4.5\text{V})$          | Total Gate Charge                     |                                                                                    | 6   | 7.5        | 9        | nC               |
| $Q_{gs}$                    | Gate Source Charge                    |                                                                                    |     | 2.5        |          | nC               |
| $Q_{gd}$                    | Gate Drain Charge                     |                                                                                    |     | 3          |          | nC               |
| $t_{D(on)}$                 | Turn-On DelayTime                     | $V_{GS}=10\text{V}$ , $V_{DS}=15\text{V}$ , $R_L=1.8\Omega$ ,<br>$R_{GEN}=3\Omega$ |     | 5          |          | ns               |
| $t_r$                       | Turn-On Rise Time                     |                                                                                    |     | 3.5        |          | ns               |
| $t_{D(off)}$                | Turn-Off DelayTime                    |                                                                                    |     | 19         |          | ns               |
| $t_f$                       | Turn-Off Fall Time                    |                                                                                    |     | 3.5        |          | ns               |
| $t_{rr}$                    | Body Diode Reverse Recovery Time      | $I_F=8\text{A}$ , $dI/dt=500\text{A}/\mu\text{s}$                                  | 6   | 8          | 10       | ns               |
| $Q_{rr}$                    | Body Diode Reverse Recovery Charge    | $I_F=8\text{A}$ , $dI/dt=500\text{A}/\mu\text{s}$                                  | 14  | 18         | 22       | nC               |

A. The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The value in any given application depends on the user's specific board design.

B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}=150^\circ\text{C}$ , using  $\leq 10\text{s}$  junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}=150^\circ\text{C}$ . Ratings are based on low frequency and duty cycles to keep initial  $T_J=25^\circ\text{C}$ .

D. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to lead  $R_{\theta JL}$  and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using  $<300\mu\text{s}$  pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, assuming a maximum junction temperature of  $T_{J(MAX)}=150^\circ\text{C}$ . The SOA curve provides a single pulse rating.

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# N-Channel: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

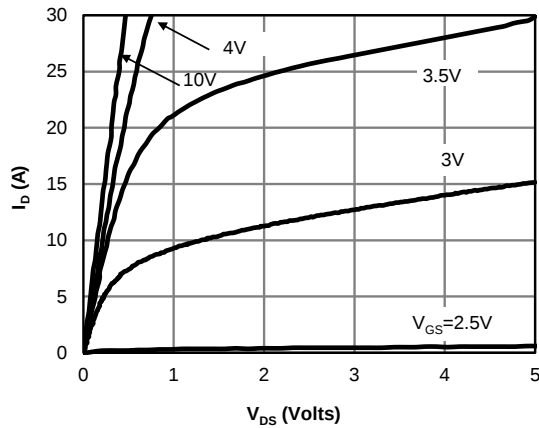


Fig 1: On-Region Characteristics (Note E)

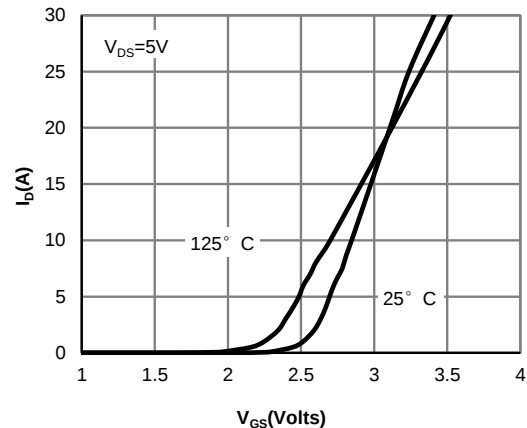


Figure 2: Transfer Characteristics (Note E)

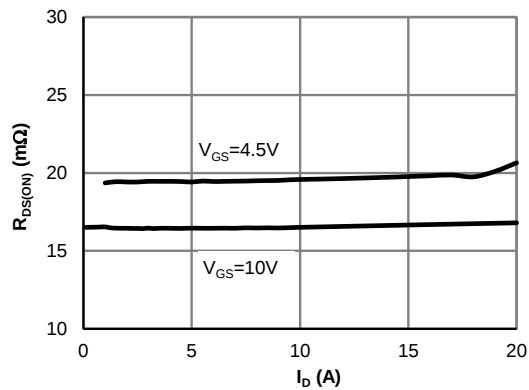


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

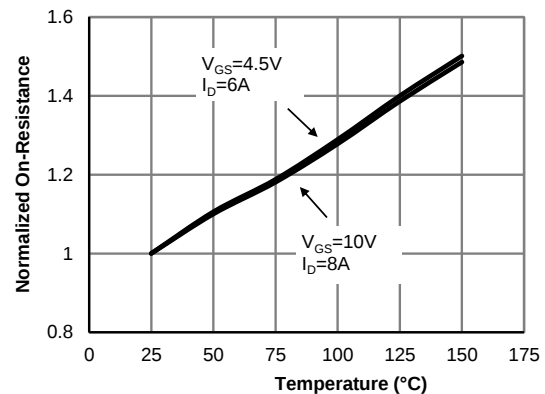


Figure 4: On-Resistance vs. Junction Temperature (Note E)

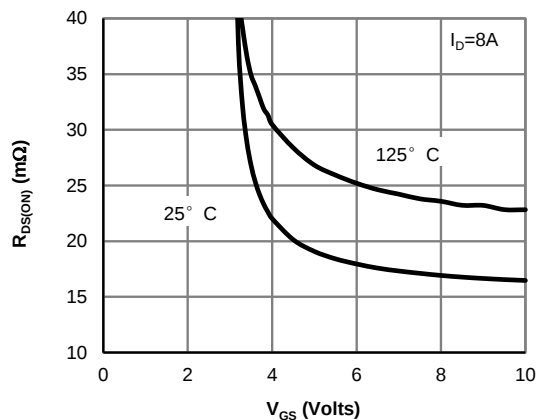


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

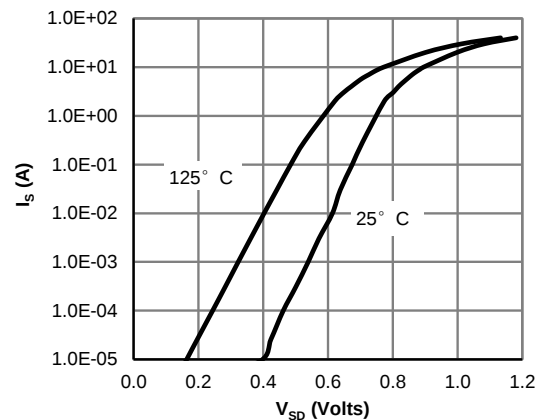
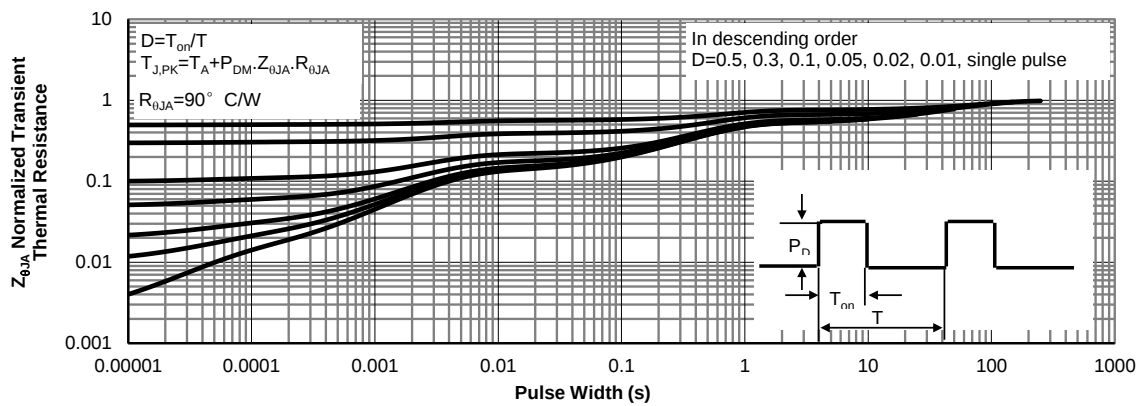
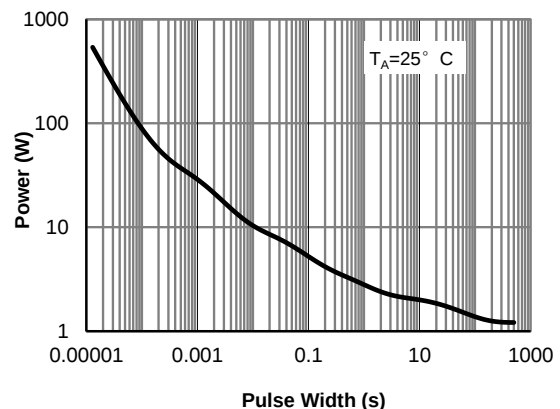
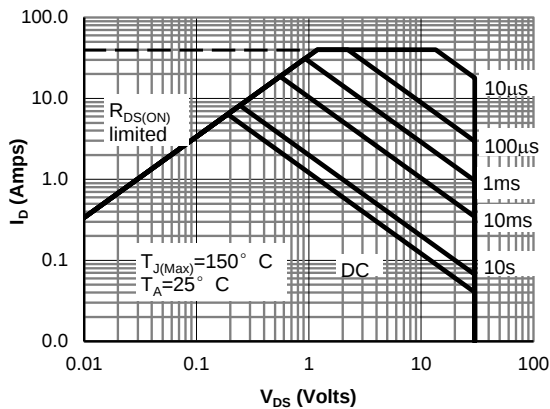
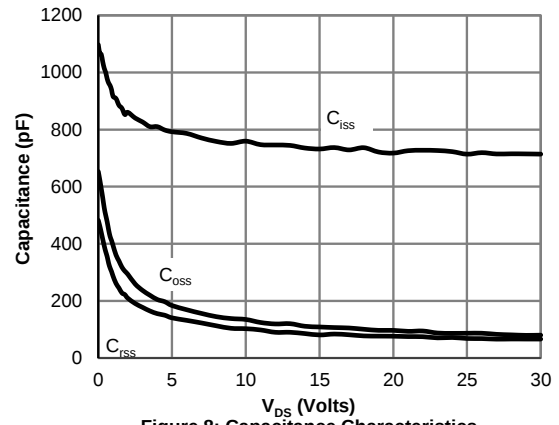
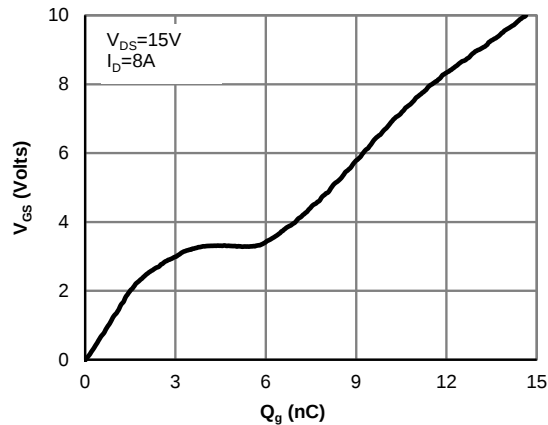
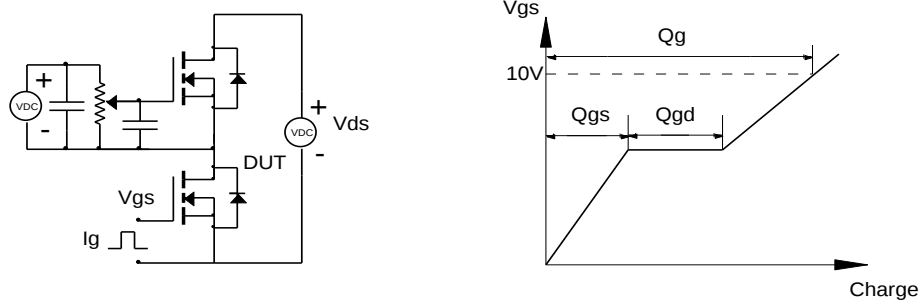


Figure 6: Body-Diode Characteristics (Note E)

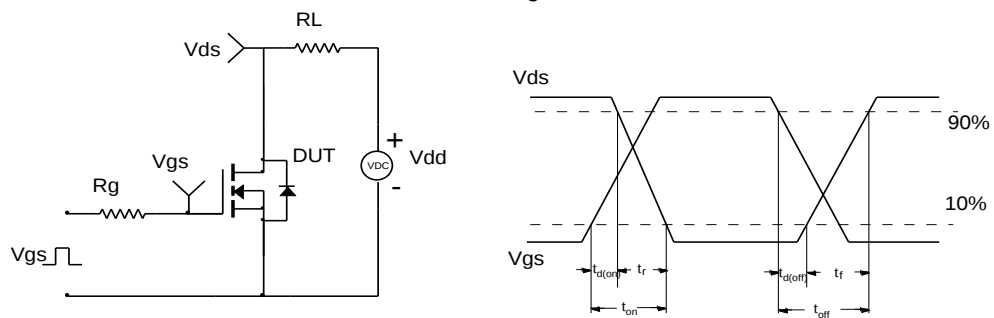
**N-Channel: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



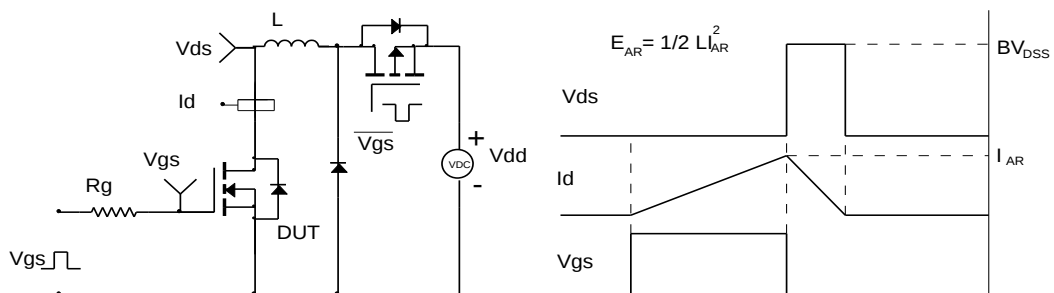
### Gate Charge Test Circuit & Waveform



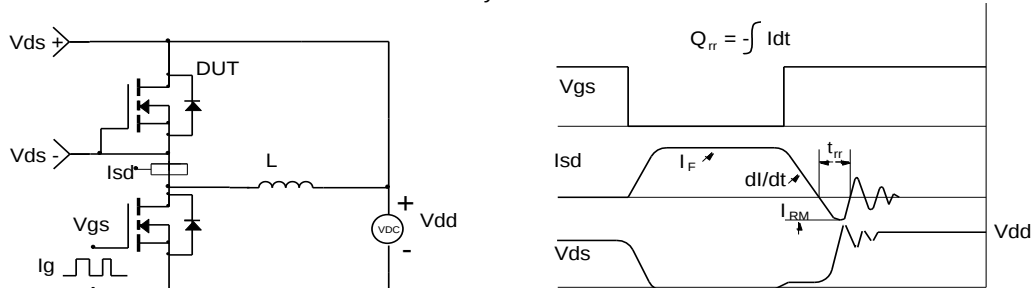
### Resistive Switching Test Circuit & Waveforms



### Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



### Diode Recovery Test Circuit & Waveforms



**P-Channel Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions                                                                          | Min  | Typ          | Max      | Units            |
|-----------------------------|---------------------------------------|-------------------------------------------------------------------------------------|------|--------------|----------|------------------|
| <b>STATIC PARAMETERS</b>    |                                       |                                                                                     |      |              |          |                  |
| $BV_{DSS}$                  | Drain-Source Breakdown Voltage        | $I_D=-250\mu\text{A}$ , $V_{GS}=0\text{V}$                                          | -30  |              |          | V                |
| $I_{DSS}$                   | Zero Gate Voltage Drain Current       | $V_{DS}=-30\text{V}$ , $V_{GS}=0\text{V}$<br>$T_J=55^\circ\text{C}$                 |      |              | -1<br>-5 | $\mu\text{A}$    |
| $I_{GSS}$                   | Gate-Body leakage current             | $V_{DS}=0\text{V}$ , $V_{GS}=\pm 20\text{V}$                                        |      |              | 100      | nA               |
| $V_{GS(th)}$                | Gate Threshold Voltage                | $V_{DS}=V_{GS}$ , $I_D=-250\mu\text{A}$                                             | -1.4 | -2.0         | -2.5     | V                |
| $I_{D(ON)}$                 | On state drain current                | $V_{GS}=-10\text{V}$ , $V_{DS}=-5\text{V}$                                          | -40  |              |          | A                |
| $R_{DS(ON)}$                | Static Drain-Source On-Resistance     | $V_{GS}=-10\text{V}$ , $I_D=-7\text{A}$<br>$T_J=125^\circ\text{C}$                  |      | 17.5<br>24.5 | 22<br>33 | $\text{m}\Omega$ |
|                             |                                       | $V_{GS}=-4.5\text{V}$ , $I_D=-3.5\text{A}$                                          |      | 27.5         | 40       | $\text{m}\Omega$ |
| $g_{FS}$                    | Forward Transconductance              | $V_{DS}=-5\text{V}$ , $I_D=-7\text{A}$                                              |      | 24           |          | S                |
| $V_{SD}$                    | Diode Forward Voltage                 | $I_S=-1\text{A}$ , $V_{GS}=0\text{V}$                                               |      | -0.75        | -1       | V                |
| $I_S$                       | Maximum Body-Diode Continuous Current |                                                                                     |      |              | -2.5     | A                |
| <b>DYNAMIC PARAMETERS</b>   |                                       |                                                                                     |      |              |          |                  |
| $C_{iss}$                   | Input Capacitance                     | $V_{GS}=0\text{V}$ , $V_{DS}=-15\text{V}$ , $f=1\text{MHz}$                         | 830  | 1040         | 1250     | pF               |
| $C_{oss}$                   | Output Capacitance                    |                                                                                     | 125  | 180          | 235      | pF               |
| $C_{rss}$                   | Reverse Transfer Capacitance          |                                                                                     | 75   | 125          | 175      | pF               |
| $R_g$                       | Gate resistance                       | $V_{GS}=0\text{V}$ , $V_{DS}=0\text{V}$ , $f=1\text{MHz}$                           | 2    | 4            | 6        | $\Omega$         |
| <b>SWITCHING PARAMETERS</b> |                                       |                                                                                     |      |              |          |                  |
| $Q_g(10\text{V})$           | Total Gate Charge                     | $V_{GS}=10\text{V}$ , $V_{DS}=-15\text{V}$ , $I_D=-7\text{A}$                       | 15   | 19           | 23       | nC               |
| $Q_g(4.5\text{V})$          | Total Gate Charge                     |                                                                                     | 7.5  | 9.6          | 12       | nC               |
| $Q_{gs}$                    | Gate Source Charge                    |                                                                                     |      | 3.6          |          | nC               |
| $Q_{gd}$                    | Gate Drain Charge                     |                                                                                     |      | 4.6          |          | nC               |
| $t_{D(on)}$                 | Turn-On DelayTime                     | $V_{GS}=10\text{V}$ , $V_{DS}=-15\text{V}$ , $R_L=2.2\Omega$ ,<br>$R_{GEN}=3\Omega$ |      | 10           |          | ns               |
| $t_r$                       | Turn-On Rise Time                     |                                                                                     |      | 5.5          |          | ns               |
| $t_{D(off)}$                | Turn-Off DelayTime                    |                                                                                     |      | 26           |          | ns               |
| $t_f$                       | Turn-Off Fall Time                    |                                                                                     |      | 9            |          | ns               |
| $t_{rr}$                    | Body Diode Reverse Recovery Time      | $I_F=-7\text{A}$ , $dI/dt=500\text{A}/\mu\text{s}$                                  |      | 11.5         | 15       | ns               |
| $Q_{rr}$                    | Body Diode Reverse Recovery Charge    | $I_F=-7\text{A}$ , $dI/dt=500\text{A}/\mu\text{s}$                                  |      | 25           | 32.5     | nC               |

A. The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The value in any given application depends on the user's specific board design.

B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}=150^\circ\text{C}$ , using  $\leq 10\text{s}$  junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}=150^\circ\text{C}$ . Ratings are based on low frequency and duty cycles to keep initial  $T_J=25^\circ\text{C}$ .

D. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to lead  $R_{\theta JL}$  and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using  $<300\mu\text{s}$  pulses, duty cycle 0.5% max.

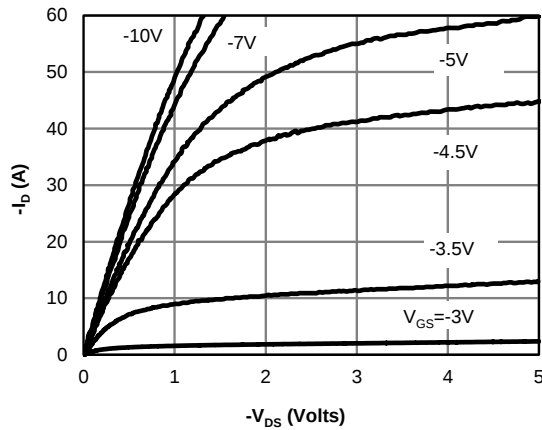
F. These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, assuming a maximum junction temperature of  $T_{J(MAX)}=150^\circ\text{C}$ . The SOA curve provides a single pulse rating.

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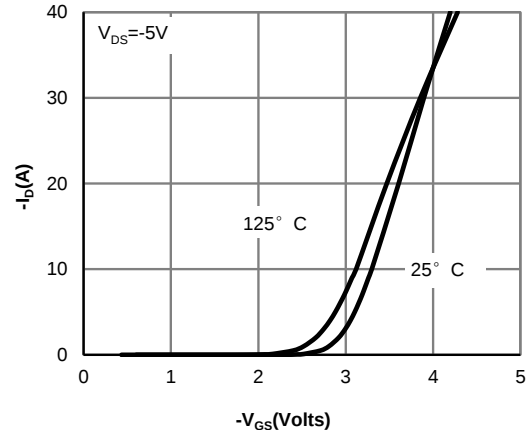
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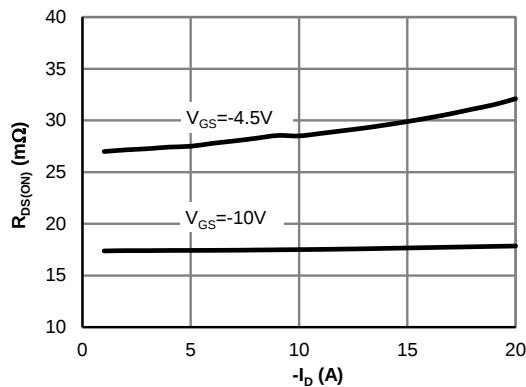
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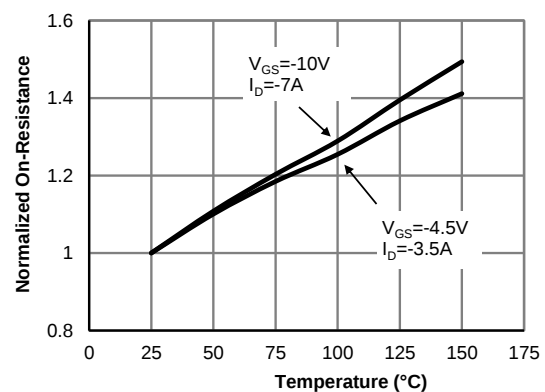
**Fig 1: On-Region Characteristics (Note E)**



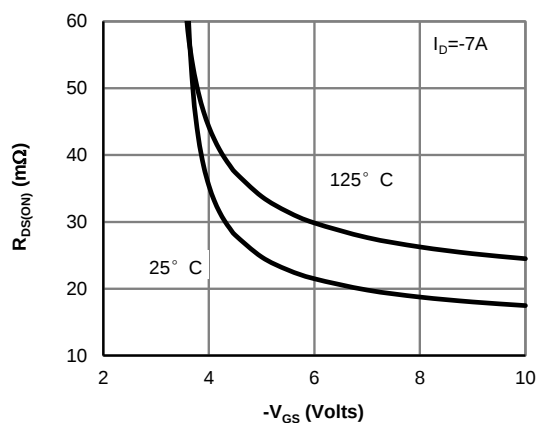
**Figure 2: Transfer Characteristics (Note E)**



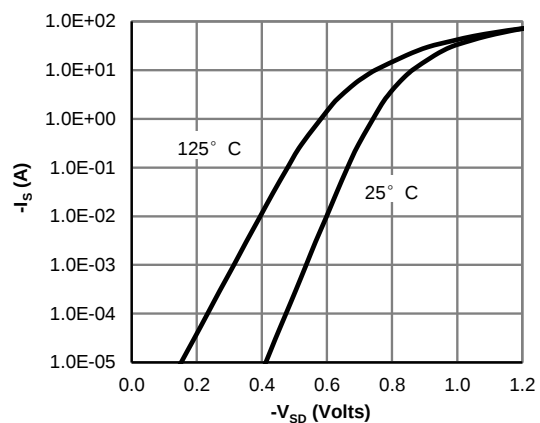
**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**



**Figure 4: On-Resistance vs. Junction Temperature (Note E)**

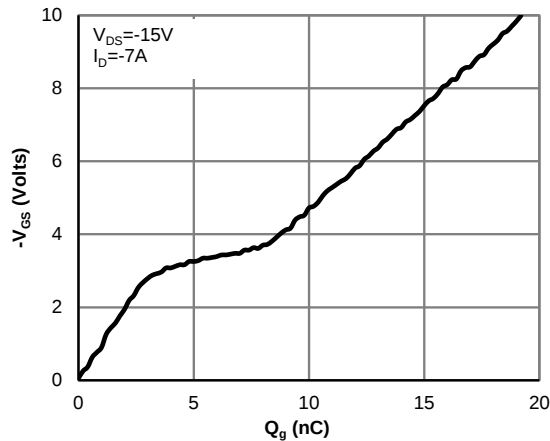


**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**

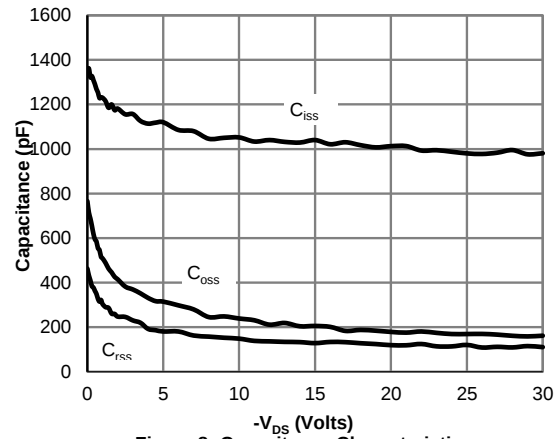


**Figure 6: Body-Diode Characteristics (Note E)**

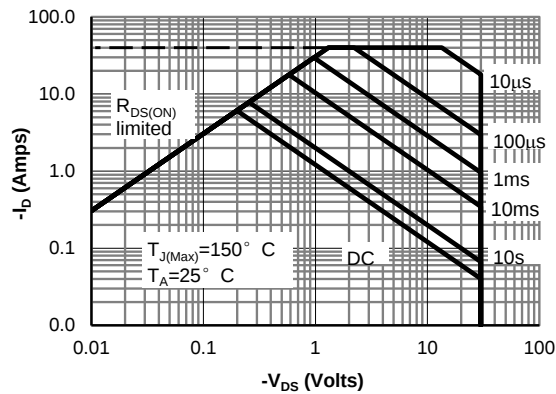
**P-Channel: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



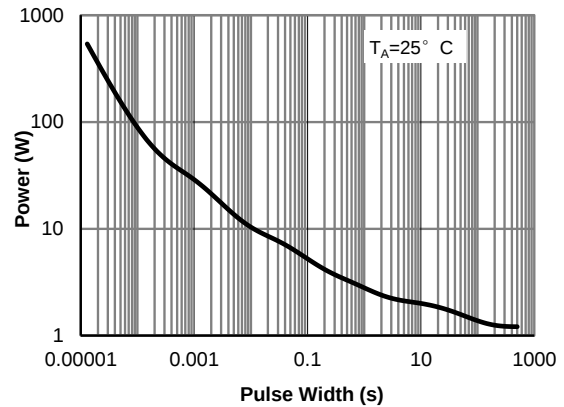
**Figure 7: Gate-Charge Characteristics**



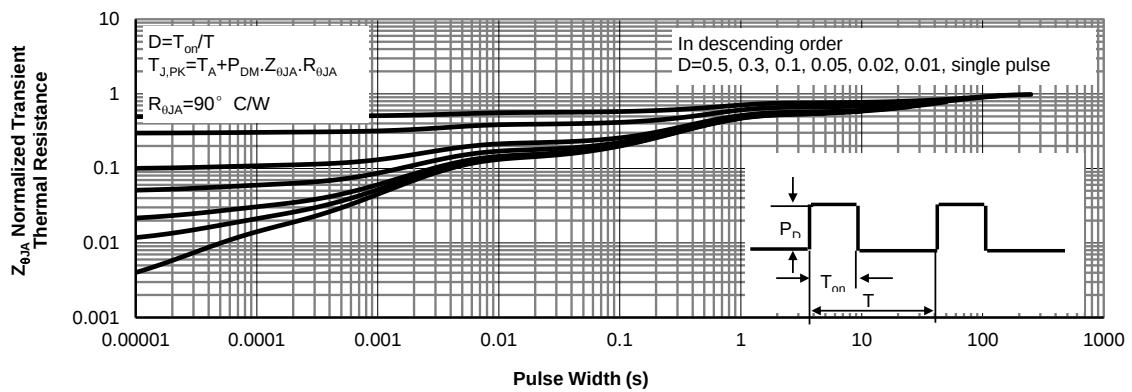
**Figure 8: Capacitance Characteristics**



**Figure 9: Maximum Forward Biased Safe Operating Area (Note F)**

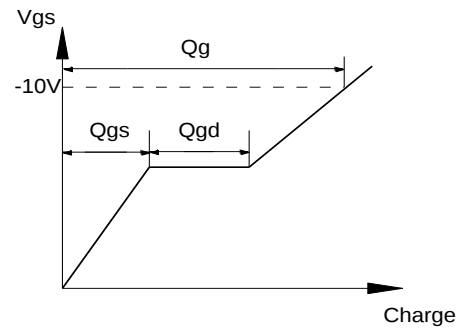
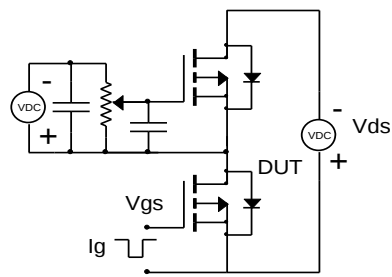


**Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note F)**

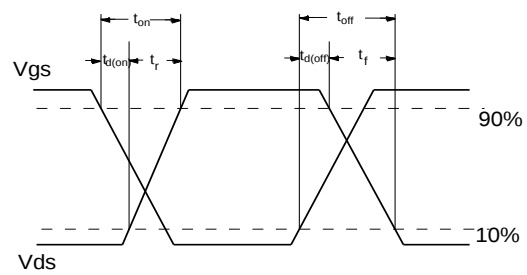
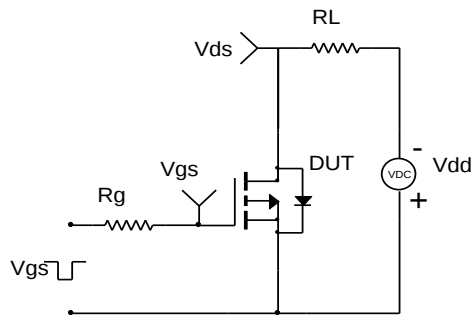


**Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)**

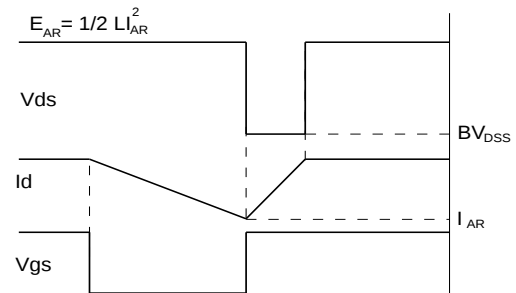
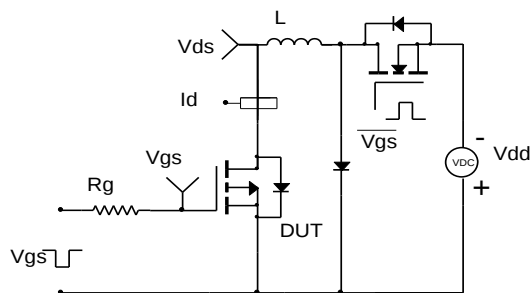
### Gate Charge Test Circuit & Waveform



### Resistive Switching Test Circuit & Waveforms



### Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



### Diode Recovery Test Circuit & Waveforms

